

<b>Notice of References Cited</b>	Application/Control No. 10/578,988		Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner Jennifer Dieterle		Art Unit 4111	Page 1 of 1

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*	D	US-2004/0005721	01-2004	Tanike et al.	436/518
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#### NON-PATENT DOCUMENTS

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